## Notice of References Cited Application/Control No. 10/584,209 Examiner SHYAM NATHAN Applicant(s)/Patent Under Reexamination STANIER ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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	Е	US-			
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	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 01/94512	12-2001	WIPO	Araya, Abraham	C11D 3/12
*	0	GB 2082454	06-1981	UK	Glemza et al.	A61K 7/16
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## **NON-PATENT DOCUMENTS**

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